



SHEET 1 OF 1

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 242935US3		SERIAL NO. 10/663,704	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Yoichi NEMUGAKI			
				FILING DATE September 17, 2003		GROUP 1731	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
JL	AA	3,881,906	05/06/1975	G. F. RITTER, JR, et al.			
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
JL	AO	1 114 800	07/11/2001	EUROPE			
	AP	1 519 292	03/29/1968	FRANCE			X
	AQ	1 450 421	06/24/1966	FRANCE			X
	AR	2 286 798	04/30/1976	FRANCE			X
	AS	11-139839	05/25/1999	JAPAN (with English Abstract)			X
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ					<input type="checkbox"/> Additional References sheet(s) attached	
Examiner /Jason Lazorcik/				Date Considered 10/06/2006			
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

9/17/03

SHEET 1 OF 1

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. <b>242935US3</b>		SERIAL NO. <b>New Application</b>	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT <b>Yoichi NEMUGAKI</b>			
				FILING DATE <b>Herewith</b>		GROUP	
<b>U.S. PATENT DOCUMENTS</b>							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
JL	AA	6,397,634	06/04/02	Takashi TAKEDA, et al.			
	AB						
	AC						
	AD						
	AE						
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	AG						
	AH						
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	AJ						
	AK						
	AL						
	AM						
	AN						
<b>FOREIGN PATENT DOCUMENTS</b>							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION		
					YES	NO	
JL	AO	2000-281369	10/10/00	Japan (with English Abstract)		X	
	AP	2000-72460	03/07/00	Japan (with English Abstract)		X	
	AQ	2000-72461	03/07/00	Japan (with English Abstract)		X	
	AR	2001-2431	01/09/01	Japan (with English Abstract)		X	
	AS	2001-2433	01/09/01	Japan (with English Abstract)		X	
	AT	2001-2434	01/09/01	Japan (with English Abstract)		X	
	AU	2001-2435	01/09/01	Japan (with English Abstract)		X	
	AV						
<b>OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)</b>							
	AW						
	AX						
	AY						
	AZ					<input type="checkbox"/> Additional References sheet(s) attached	
Examiner <b>/Jason Lazorcik/</b>					Date Considered <b>10/06/2006</b>		
<small>*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</small>							